

Search Notes

Application/Control No.

10/688,019

Examiner

Shin-Hon Chen

Applicant(s)/Patent under
Reexamination

SPIES ET AL.

Art Unit

2131

SEARCHED

Class	Subclass	Date	Examiner
713	156,175	5/25/2006	S.C.
380	277-279	5/25/2006	S.C.
726	3	5/25/2006	S.C.

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
380	277-279	5/25/2006	S.C.
713	156,175	5/25/2006	S.C.
726	3	5/25/2006	S.C.

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
USPAT, PGPUB, JPO, EPO, DERWENT (BRS Search)	5/25/2006	S.C.